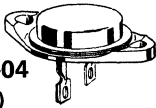


2N1073, A, B (GERMANIUM)



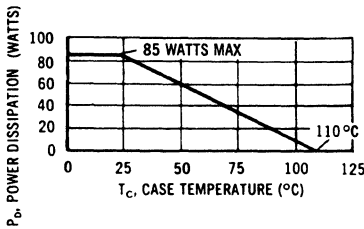
CASE 4-04
(TO-41)

PNP germanium power transistors for high-voltage power switching applications.

MAXIMUM RATINGS

Rating	Symbol	2N1073	2N1073A	2N1073B	Unit
Collector-Emitter Voltage	V_{CE}	40	80	120	Vdc
Collector-Base Voltage	V_{CB}	40	80	120	Vdc
Emitter-Base Voltage	V_{EB}	1.5	1.5	1.5	Vdc
Collector Current (Cont)	I_C	10	10	10	Amp
Base Current (Cont)	I_B	5.0			Amp
Emitter Reverse Current (Surge 60 cps Recurrent)	I_E	1.5			Amp
Storage and Operating Temperature	T_{stg} T_J	-65 to +110			$^{\circ}C$
Collector Dissipation (25 $^{\circ}C$ Mtg. Case Temp.)	P_D	85			Watts

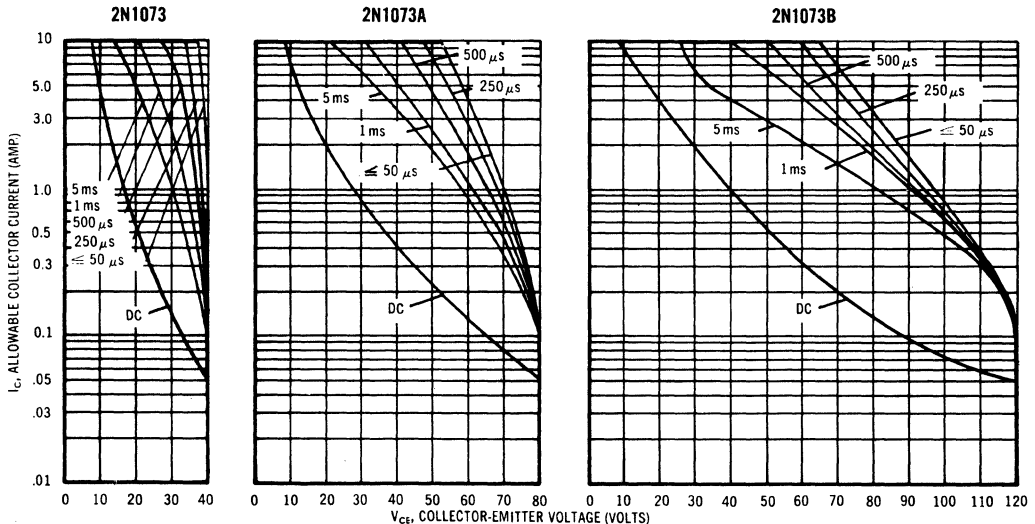
POWER-TEMPERATURE DERATING CURVE



The maximum continuous power is related to maximum junction temperature by the thermal resistance factor. This curve has a value of 85 watts at a case temperature of 25 $^{\circ}C$ and is 0 watts at 110 $^{\circ}C$ with a linear relation between the two temperatures such that:

$$\text{Allowable } P_D = \frac{110^{\circ} - T_C}{1.0} \text{ Watts}$$

SAFE OPERATING AREAS — PULSE CONDITIONS



The Safe Operating Area Curves indicate $I_C - V_{CE}$ limits below which the device will not go into secondary breakdown. Collector load lines for specific circuits must fall within the applicable Safe Area to avoid causing a collector-emitter short.

(Duty cycle of the excursions make no significant change in these safe areas.) To insure operation below the maximum T_J , the power-temperature derating curve must be observed for both steady state and pulse power conditions.

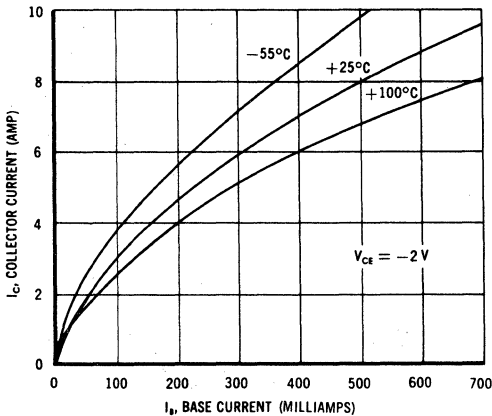
2N1073, A, B (continued)

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

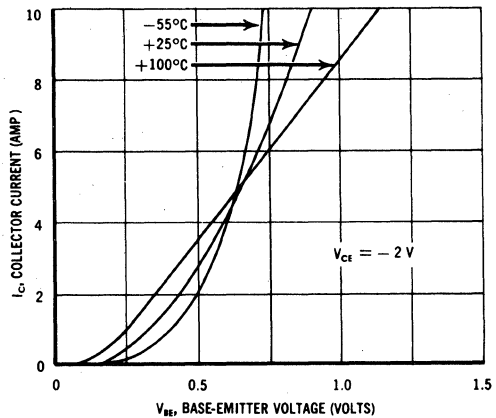
Characteristic	Symbol	Min	Typ	Max	Unit
Collector-Base Cutoff Current ($V_{CB} = 25 \text{ Vdc}$, $I_E = 0$)	I_{CBO}	-	-	1.0	mAdc
($V_{CB} = 25 \text{ Vdc}$, $I_E = 0$, $T_C = 85^\circ\text{C}$)				15	
($V_{CB} = 40 \text{ Vdc}$, $I_E = 0$)				20	
($V_{CB} = 60 \text{ Vdc}$, $I_E = 0$)				1.0	
($V_{CB} = 60 \text{ Vdc}$, $I_E = 0$, $T_C = 85^\circ\text{C}$)				15	
($V_{CB} = 80 \text{ Vdc}$, $I_E = 0$)				20	
($V_{CB} = 100 \text{ Vdc}$, $I_E = 0$)				2.0	
($V_{CB} = 100 \text{ Vdc}$, $I_E = 0$, $T_C = 85^\circ\text{C}$)				20	
($V_{CB} = 120 \text{ Vdc}$, $I_E = 0$)				20	
($V_{CB} = 2.0 \text{ Vdc}$, $I_E = 0$)	-	-	0.3		
Emitter-Base Leakage Current ($V_{EB} = 0.75 \text{ Vdc}$)	I_{EBO}	-	-	50	mAdc
Emitter Floating Potential ($V_{CE} = 40 \text{ Vdc}$)	V_{EBF}	-	-	1.0	Vdc
($V_{CE} = 80 \text{ Vdc}$)				1.0	
($V_{CE} = 120 \text{ Vdc}$)				1.0	
Collector-Emitter Breakdown Voltage* ($I_C = 50 \text{ mAdc}$, $R_{BE} = 100\Omega$)	BV_{CER}^*	40	-	-	Vdc
				80	
				120	
DC Current Gain ($I_C = 5.0 \text{ Adc}$, $V_{CE} = 2.0 \text{ Vdc}$)	h_{FE}	20	-	60	-
Small-Signal Current Gain ($I_C = 0.5 \text{ Adc}$, $V_{CE} = 12 \text{ Vdc}$, $f = 30 \text{ kHz}$)	h_{fe}	-	15	-	-
Base Input Voltage ($V_{CE} = 2.0 \text{ Vdc}$, $I_C = 5.0 \text{ Adc}$)	V_{BE}	-	-	1.0	Vdc
Collector-Emitter Saturation Voltage ($I_C = 5.0 \text{ Adc}$, $I_B = 0.5 \text{ Adc}$)	$V_{CE(sat)}$	-	0.5	1.0	Vdc
Rise Time	t_r	-	5.5	-	μs
Storage Time	t_s	-	1.2	-	μs
Fall Time	t_f	-	2.0	-	μs

*To avoid excessive heating of collector junction, perform this test with a sweep method.

COLLECTOR CURRENT versus BASE CURRENT

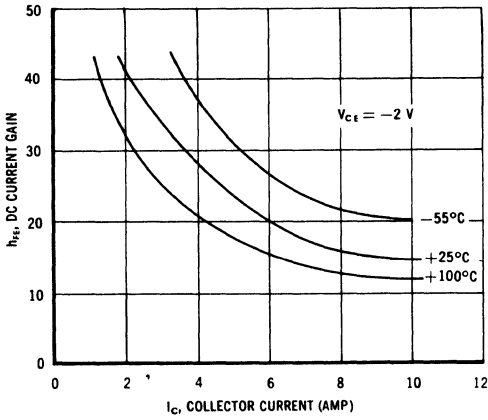


COLLECTOR CURRENT versus DRIVE VOLTAGE

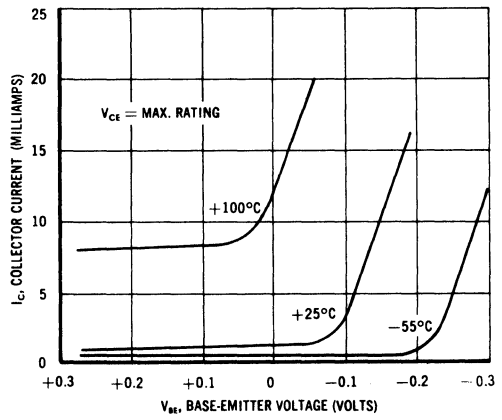


2N1073, A, B (continued)

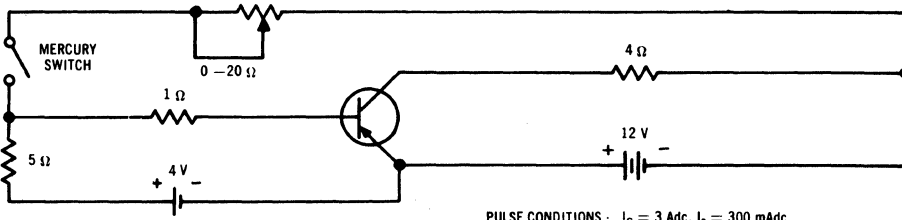
DC CURRENT GAIN versus COLLECTOR CURRENT



COLLECTOR CURRENT versus DRIVE VOLTAGE



SWITCHING TEST CIRCUIT



PULSE CONDITIONS ; $I_C = 3\text{ A dc}$, $I_B = 300\text{ mAdc}$

2N1099 (GERMANIUM)

For Specifications, See 2N277 Data.

2N1100 (GERMANIUM)

For Specifications, See 2N174 Data.